

# **MOSFET** – P-Channel, Logic Level, POWERTRENCH®

-40 V, -65 A, 8.0 m $\Omega$ 

# FDWS9509L-F085

#### **Features**

- Typ  $R_{DS(on)} = 6.3 \text{ m}\Omega$  at  $V_{GS} = -10 \text{ V}$ ;  $I_D = -65 \text{ A}$
- Typ  $Q_{g(tot)} = 48 \text{ nC}$  at  $V_{GS} = -10 \text{ V}$ ;  $I_D = -65 \text{ A}$
- UIS Capability
- Wettable Flanks for Automatic Optical Inspection (AOI)
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb–Free, Halogen Free/BFR Free and is RoHS Compliant

## **Applications**

- Automotive Engine Control
- PowerTrain Management
- Solenoid and Motor Drivers
- Electronic Steering
- Integrated Starter/Alternator
- Distributed Power Architectures and VRM
- Primary Switch for 12 V Systems

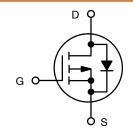
# MOSFET MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain-to-Source Voltage		V <sub>DSS</sub>	-40	V
Gate-to-Source Voltage		V <sub>GS</sub>	±16	V
Continuous Drain Current (V <sub>GS</sub> = 10 V) (Note 1)			-65	Α
Pulsed Drain Current	T <sub>C</sub> = 25°C		See Figure 4	
Single Pulse Avalanche Energy (Note 2)		E <sub>AS</sub>	84	mJ
Power Dissipation		$P_{D}$	107	W
Derate above 25°C			0.71	W/°C
Operating and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to +175	°C
Thermal Resistance (Junction-to-Case)		$R_{\theta JC}$	1.4	°C/W
Maximum Thermal Resistance (Junction-to-Ambient) (Note 3)		$R_{\theta JA}$	50	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Current is limited by wirebond configuration.
- 2. Starting Tj = 25°C, L = 50  $\mu$ H, I<sub>AS</sub> = 56 A, V<sub>DD</sub> = -40 V during inductor charging and V<sub>DD</sub> = 0 V during time in avalanche.
- 3.  $R_{\theta JA}$  is the sum of the junction–to–case and case–to–ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2 oz copper.

V <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
-40 V	8.0 mΩ @ –10 V	-65 A



P-Channel MOSFET



DFNW8 CASE 507AU

#### **MARKING DIAGRAM**



A = Assembly Location

= Year

WW = Work Week
WL = Assembly Lot

FDWS9509L = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FDWS9509L-F085	DFNW8 (Power 56) (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Con	Conditions		Тур	Max	Unit
OFF CHARA	ACTERISTICS	•		•	•	<u>.                                    </u>	
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$		-40	-	-	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C	-	-	1	μΑ
			T <sub>J</sub> = 175°C (Note 4)	-	-	1	mA
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>GS</sub> = ±16 V		-	-	±100	nA
ON CHARA	CTERISTICS						
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -25$	60 μΑ	-1	-1.7	-3	V
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	I <sub>D</sub> = -65 A, V <sub>GS</sub> = -4	4.5 V	-	10.7	15.3	mΩ
		I <sub>D</sub> = -65 A V <sub>GS</sub> = -10 V	T <sub>J</sub> = 25°C	-	6.3	8.0	mΩ
		$V_{GS} = -10 \text{ V}$	T <sub>J</sub> = 175°C (Note 4)	-	10.6	13.0	
DYNAMIC C	HARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		-	3360	-	pF
C <sub>oss</sub>	Output Capacitance			-	1230	-	
C <sub>rss</sub>	Reverse Transfer Capacitance			-	38	-	
R <sub>g</sub>	Gate Resistance	V <sub>GS</sub> = 0.5 V, f = 1 MHz		-	21	-	Ω
Q <sub>g(tot)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 to -10 V	V <sub>DD</sub> = −20 V,	-	48	67	nC
Q <sub>g(th)</sub>	Threshold Gate Charge	V <sub>GS</sub> = 0 to -2 V		-	7	-	
$Q_{gs}$	Gate-to-Source Gate Charge			-	12	-	
$Q_{gd}$	Gate-to-Drain "Miller" Charge			-	6	-	
SWITCHING	CHARACTERISTICS						
t <sub>on</sub>	Turn-On Time	$V_{DD}$ = -20 V, $I_{D}$ = -65 A, $V_{GS}$ = -10 V, $R_{GEN}$ = 6 $\Omega$		-	-	22	ns
t <sub>d(on)</sub>	Turn-On Delay			-	10	-	
t <sub>r</sub>	Rise Time			-	5	-	
t <sub>d(off)</sub>	Turn-Off Delay			-	198	-	
t <sub>f</sub>	Fall Time			-	71	-	
t <sub>off</sub>	Turn-Off Time			-	-	405	
DRAIN-SOL	JRCE DIODE CHARACTERISTICS						
$V_{SD}$	Source-to-Drain Diode Voltage $I_{SD} = -65 \text{ A}, V_{GS} = 0 \text{ V}$		) V	-	1.0	-1.25	V
		I <sub>SD</sub> = -32.5 A, V <sub>GS</sub> =	= 0 V	-	0.9	-1.2	
t <sub>rr</sub>	Reverse Recovery Time	$I_F = -65 \text{ A}, \text{ d}I_{SD}/\text{d}t = 100 \text{ A}/\mu\text{s}$		-	57	80	ns
Q <sub>rr</sub>	Reverse Recovery Charge			-	45	67	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. The maximum value is specified by design at T<sub>J</sub> = 175°C. Product is not tested to this condition in production

## **TYPICAL CHARACTERISTICS**

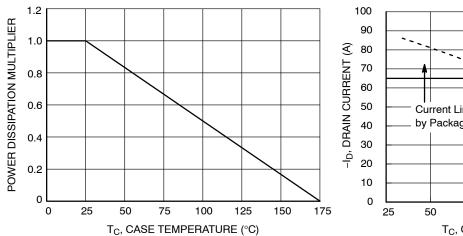


Figure 1. Normalized Power Dissipation vs.

Case Temperature

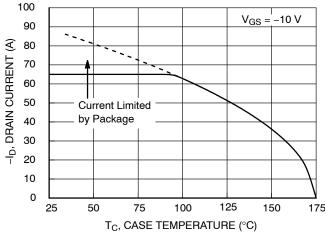


Figure 2. Maximum Continuous Drain Current vs.

Case Temperature

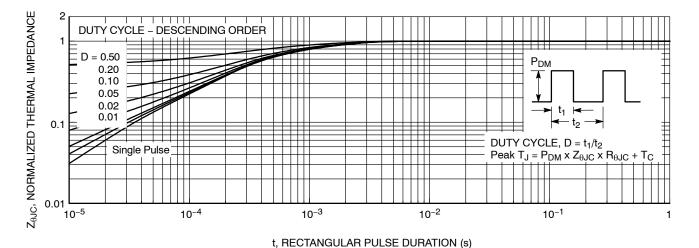


Figure 3. Normalized Maximum Transient Thermal Impedance

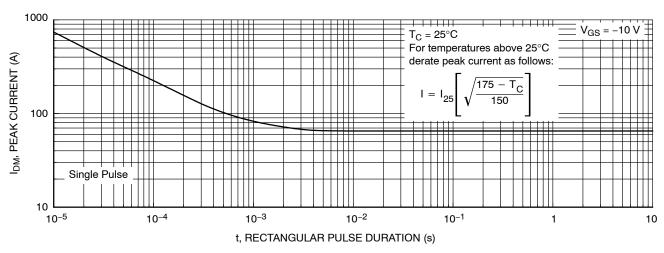


Figure 4. Peak Current Capability

#### TYPICAL CHARACTERISTICS (continued)

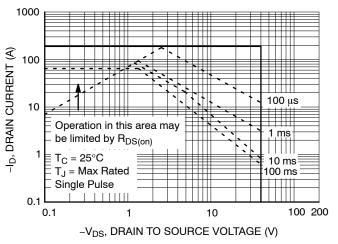


Figure 5. Forward Bias Safe Operating Area

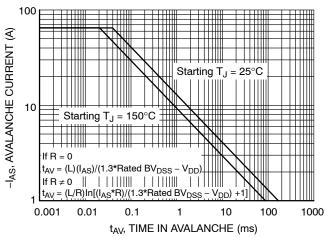


Figure 6. Unclamped Inductive Switching Capability

(Note: Refer to **onsemi** Applications Notes <u>AN7514</u> and <u>AN7515</u>)

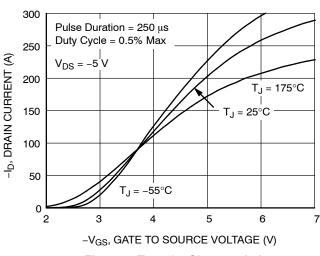


Figure 7. Transfer Characteristics

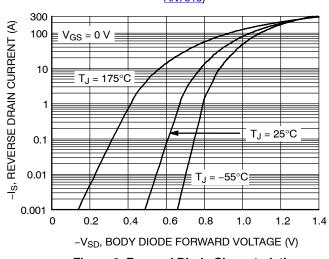


Figure 8. Forward Diode Characteristics

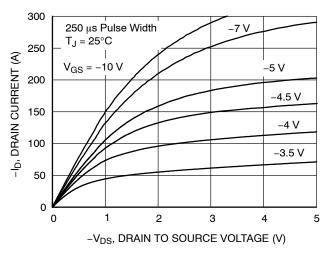


Figure 9. Saturation Characteristics

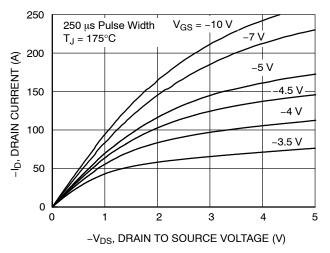


Figure 10. Saturation Characteristics

## TYPICAL CHARACTERISTICS (continued)

NORMALIZED DRAIN-TO-SOURCE

1.7

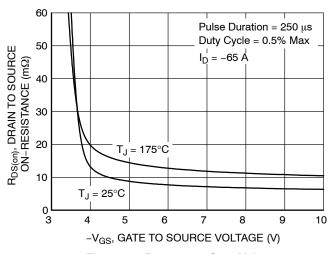
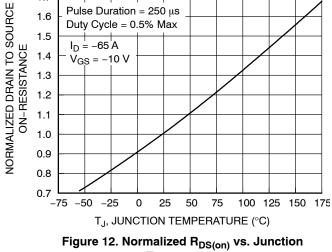


Figure 11. R<sub>DS(on)</sub> vs. Gate Voltage



Temperature

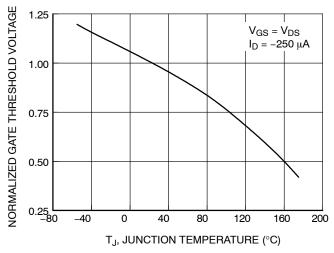


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

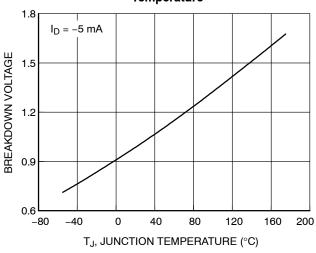


Figure 14. Normalized Drain to Source **Breakdown Voltage vs. Junction Temperature** 

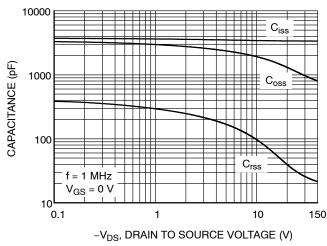


Figure 15. Capacitance vs. Drain to Source Voltage

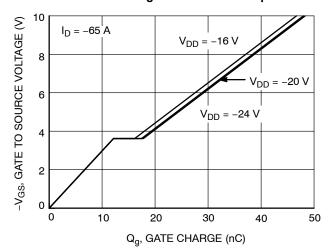
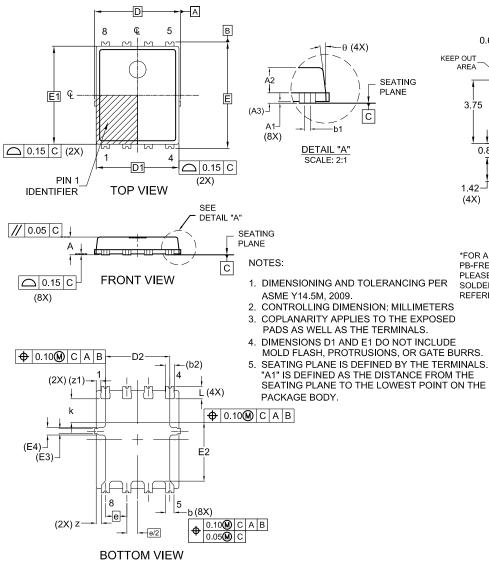
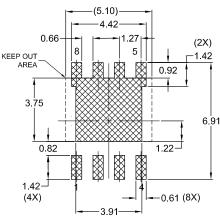


Figure 16. Gate Charge vs. Gate to Source Voltage

#### PACKAGE DIMENSIONS

# **DFNW8 5.2x6.3, 1.27P**CASE 507AU ISSUE A





LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRIMD.

DIM	MILLIMETERS			
Diwi	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	-	-	0.05	
A2	0.65	0.75	0.85	
A3	·	0.30 REF	•	
b	0.47	0.52	0.57	
b1	0.13	0.18	0.23	
b2		(0.54)		
D	5.00	5.10	5.20	
D1	4.80	4.90	5.00	
D2	3.72	3.82	3.92	
Е	6.20	6.30	6.40	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.58	
E3	0.30 REF			
E4	0.45 REF			
е	1.27 BSC			
e/2	0.635BSC			
k	1.30	1.40	1.50	
L	0.64	0.74	0.84	
Z	0.24	0.29	0.34	
z1	(0.28)			
θ	0°		12°	

POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative